# TPC electronics calibration with pulser in cold box data

# **BNL DUNE**

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#### Introduction

I look at APA data from CERN

- Data available at CERN and FNAL
  - <u>https://wiki.dunescience.org/wiki/Accessing\_ProtoDUNE-SP\_Cold\_Box\_Test\_Data\_in\_LArSoft</u>
- Single APA in a cold box
  - Expect to find 2560 channels: 20 FEMB × 128 chan/FEMB
  - o For APA5 testing, 12/20 FEMBs have data → 1536 channels
- Some data taken with pulser
  - DAC = 1, 2, ..., 10 (See following page)
- Use this data to calibrate the TPC electronics
  - I.e. convert ADC count to input charge

## Pulser

#### Pulser

- DAC used induce voltage shift V<sub>in</sub> at input to preamp
  - $\circ$  (As does a moving charge in the vicinity of an anode wire)
  - $_{\odot}$   $\,$  Voltage shifted up and then back down periodically
  - Rising and falling edges inject charge
- With known input capacitance C, the charge injection is Q<sub>in</sub> = C V<sub>in</sub>
  - DAC setting of P = 0, 1, 2,..., 63 should give  $V_{in} = P V_{step}$

$$\rightarrow$$
 Q<sub>in</sub> = P Q<sub>step</sub> where

Q<sub>step</sub> = C V<sub>step</sub> = (183 fF) (18.75 mV) = 3.43 fC = 21.4 ke

- Two options for the pulser
  - Internal: DAC is on the preamp ASIC
  - External: DAC on the FEMB
- APA5 data taken with internal pulser
  - Behavior does not follow the above ideal
  - There is a channel-dependent offset:  $V_{in} = V_{off} + P V_{step}$  for P > 1
  - P = 1 has additional channel dependence
  - Ignore P = 1 and, for P > 1, assume  $Q_{in} = Q_{off} + P Q_{step}$

P = 1 is about 1 MIP

#### Analysis procedure

For each channel and pulser setting

- Evaluate and subtract pedestal
- Find ROIs
  - ROI = region of interest, range of ticks where signal appear
  - One ROI should be one pulse, i.e. a step up or down in the input voltage
  - Simple threshold algorithm is sufficient to find these pulses which are well above the noise level
- Process ROIs
  - Separate analysis for positive and negative signals
  - Fit each ROI with coldelec function
    - Vary height, shaping time and position in fit
  - Create summary histograms with the mean values of
    - height
    - shaping time
    - chi-square
    - chi-square/DOF
- Sample fcl in appendix (uses Tool-based data prep)

#### Evaluate gain for each channel

• Using observed height distributions for multiple pulser settings

#### Example ROI fits (run 1193, pulser=3)



# Example summary height and shaping (1/1200)



## Example summary chi-square (1/1200)



ROI normalized fit  $\chi^2$ /DOF run 1193 channel 500

#### Pulse fit quality

Following slides show fit quality for 200 channels

- Mean value from distributions like those on previous page
- For the 7 different DAC settings
- Two plots
  - Raw chi-square (from fit without errors)
  - Normalized chi-square dividing by DOF and using the pedestal RMS as the uncertainty for each ADC bin
- Results very good for positive pulses
  - Corrected mean chi-square/DOF is close to one except at the highest DAC setting where saturation (clipping) is evident by eye
- Negative pulse quality degrades as DAC setting is increased
  - $\circ$  Not clear why this is











Normalized fit  $\chi^2/\text{DOF}$ 



#### Gain evaluation

Use pulser data to measure gains

- I.e. ADC count out for a given input charge
  - Input charge follows from the height of the pulser voltage step
- Using preceding model for input charge, expect (ADC pedestal)

A = g Qin

= g ( $Q_{off}$  + P  $Q_{step}$ )

= S (P +  $P_{off}$ )  $Q_{step}$  g

where S = +1 for the rising edges and -1 for the falling edges

- Fit for g (and Poff) using measured A for P = 2, 3, ...
  - Stop when pulse saturates (amplifier or ADC)
  - Larger values of P may identify limits of ADC range
- A is the mean of the height for DAC setting P
  - RMS of this is used as error in A for the fit

#### Gain fits







DAC on a







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DAC too a



































Height vs. DAC channel 529

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Height vs. DAC channel 524 Gaih: 275.3 (ADC count)/O ginp



















DAC on a

-1000

2000



















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DAC on a





#### Height vs. DAC channel 549



































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Height vs. DAC channel 605





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Calibration with pulser signals in cold box data















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Height vs. DAC channel 665







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Height vs. DAC channel 685



Height vs. DAC channel 689

































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#### Gain and offset fits results vs. channel



#### Fit quality vs. channel



#### Fit distributions (channels 500-699)



## Summary/conclusions

Pulser data used to obtain TPC electronics calibration

- The gain, (input charge)/(ADC count), for each channel
  - So far for 200 induction channels
  - $_{\odot}$   $\,$  Data taken with preamp gain of 25 mV/fC and 2  $\mu s$  shaping
  - Result is an average gain of 78 e/(ADC count) with  $\sigma$  = 3.2%
- Pedestal was evaluated first (see earlier talks)
- Gain is an average over a broad range of the ADC
  - More work needed to correct for non-linearity or get response in the single MIP region
  - Pulses alone give only coarse calibration
  - But may be able to use points on the pulse waveform to go finer
- Above is a pulse height calibration
  - Valid for isolated signal with charge collection time << 2  $\mu s$
  - I think we want a pulse area calibration—right?
    - Straightforward to obtain this from pulser data
  - A bit more channel-to-channel variation because shaping time varies

#### Future

Study few % of channels with poor fits Look at remaining channels in APA 5

- The other 1336 channels
- Including collection with different pedestal location

Area calibration?

Calibrate

- Put gains in calibration tool and validate
- Search each channel for sticky ADC codes
  - Determine extent of the problem
    - $_{\odot}$   $\,$  Use pulser data to determine implication with and without mitigation
  - Most of the data is is in the pedestal region and we can do a thorough characterization there
  - Use samples along the pulse waveform to examine other regions
    - Vary pulser DAC and offset to illuminate most of the ADC range
    - Good fit quality suggests this will work well for the positive pulses
    - Like to understand why fit quality degrades for negative pulses at high DAC settings

#### Extras

#### Data prep service configuration

```
RawDigitPrepService: {
    service provider: ToolBasedRawDigitPrepService
    LogLevel: 3
    DoWires: false
    AdcChannelToolNames:
       "digitReader", Extract raw data and pedestal from raw::RawDigit
                                                   Find pedestals
       "adcPedestalFit",
       "pdapa adcChannelPedestalRmsPlotter",
                                                    Display RMS
       "adcSampleFiller",
                             Subtract pedestal, trivial calibration
       "adcThresholdSignalFinder",
                                                      Find ROIs
       "adcRoiFitterPos",
                                                    Process ROIs
       "adcRoiFitterNeg"
```

# Configuration of ROI processing tool (obsolete)

<pre>tools.adcRoiFitterPos: @local::tools.adcRoiFitter tools.adcRoiFitterPos.LogLevel: 2 tools.adcRoiFitterPos.SigThresh: 100.0 tools.adcRoiFitterPos.RoiHistOpt: 1 tools.adcRoiFitterPos.FitOpt: 1 tools.adcRoiFitterPos.RoiRootFileName: "roiroipos.root" tools.adcRoiFitterPos.SumRootFileName: "roisumpos.root" tools.adcRoiFitterPos.ChanSumRootFileName: "roichanpos.r tools.adcRoiFitterPos.ChanSumRootFileName: "roichanpos.r</pre>	Fit with coldelec functio Output root files	on Summary histo	ograms
<pre>tools.adcRofFitterPos.SumHists: [     {var:fitHeight name:"hfh_ch%0CHAN%" title:"ROI     {var:fitHeight name:"hfhw_ch%0CHAN%" title:"ROI     {var:fitWidth name:"hfw_ch%0CHAN%" title:"ROI     {var:fitWidth name:"hfpw_ch%0CHAN%" title:"ROI     {var:fitPosition name:"hfp_ch%0CHAN%" title:"ROI     {var:fitTickRem name:"hfp_ch%0CHAN%" title:"ROI     {var:fitPeriodRem name:"hftw_ch%0CHAN%" title:"ROI     {var:fitChiSquare name:"hfcsmdw_ch%0CHAN%" title:"ROI     {var:fitCNormDof name:"hfcsndw_ch%0CHAN%" title:"ROI</pre>	<pre>fit height channel %CHAN%" fit height channel %CHAN%" fit width channel %CHAN%" fit width channel %CHAN%" fit position channel %CHAN%" fit position remainder channel %CHAN% fit period remainder channel %CHAN%" fit #chi^{2} channel %CHAN%" normalized fit #chi^{2}/DOF channel %</pre>	nbin:100 xmin:100 nbin:100 xmin:0 nbin:100 xmin:4.0 nbin:100 xmin:0.0 nbin:100 xmin:0.0 %" nbin:100 xmin:-0.5 nbin:500 xmin:-250 nbin:100 xmin:0.0 %CHAN%" nbin:100 xmin:0.0	<pre>xmax:5 fit:gaus}, xmax:0 fit:gaus}, xmax:4.5 fit:gaus}, xmax:10000 }, xmax:0.5 fit:gaus}, xmax:250 }, xmax:0.0 }, xmax:0.0 },</pre>
] tools.adcRoiFitterPos.ChannelRanges: [ {name:apa1u begin:0 end:800 label:"APA1u"} ]			
<pre>tools.adcRoiFitterPos.ChanSumHists: [     {name:"hcsHeight_%CRNAME%" title:"ROI fit height ru</pre>	un %RUN% %CRLABEL%"	valHist:"hfh_ch%0CHAN%"	valType:fitMean
<pre>cr:apalu},   {name:"hcsShaping_%CRNAME%" title:"ROI fit shaping t   cr:apalu},   {name:"hcsChiSquare %CRNAME%" title:"ROI fit #cbi^(2)</pre>	time run %RUN% %CRLABEL%"	valHist:"hfw_ch%0CHAN%"	valType:fitMean
<pre>cr:apa1u},     {name:"hcsCSNormDof_%CRNAME%" title:"ROI fit Normalize     cr:apa1u}</pre>	ed #chi^{2}/DOF run %RUN% %CRLABEL%" v	valHist:"hfcsndw_ch%0CHAN%"	valType:mean
]	K		

#### Channel summary histograms